

**Search Notes**

Application/Control No.

10/533,918

Examiner

Nguyen T. Ha

Applicant(s)/Patent under  
Reexamination

OZAWA ET AL.

Art Unit

2831

**SEARCHED**

Class	Subclass	Date	Examiner
361	523-525	2/26/2007	NH
	527-534		
	516-519		
29	25.01		
	25.03		
252	62.2		

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST SEARCH (SEE SEARCH HISTORY)	2/26/2007	NH